

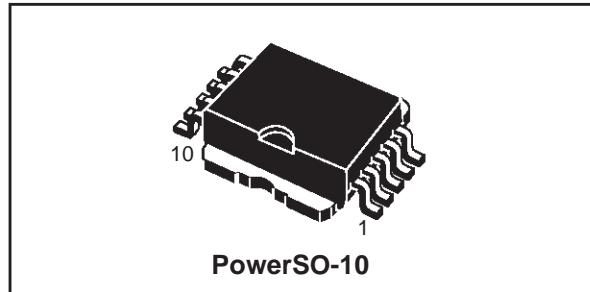


STV160NF02L

N-CHANNEL 20V - 0.0016Ω - 160A PowerSO-10
STripFET™ POWER MOSFET

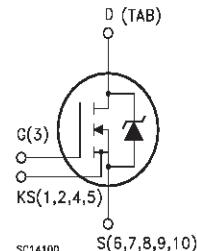
| TYPE | V _{DSS} | R _{D(on)} | I _D |
|-------------|------------------|--------------------|----------------|
| STV160NF02L | 20 V | < 0.0025 Ω | 160 A |

- TYPICAL R_{D(on)} = 0.0016 Ω
- LOW THRESHOLD DRIVE
- ULTRA LOW ON-RESISTANCE
- ULTRA FAST SWITCHING
- 100% AVALANCHE TESTED
- VERY LOW GATE CHARGE
- LOW PROFILE, VERY LOW PARASITIC INDUCTANCE PowerSO-10 PACKAGE

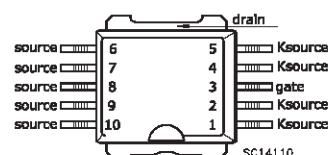


PowerSO-10

INTERNAL SCHEMATIC DIAGRAM



CONNECTION DIAGRAM (TOP VIEW)



DESCRIPTION

The **STV160NF02L** represents the second generation of Application Specific STMicroelectronics well established STripFET™ process based on a very unique strip layout design. The resulting MOSFET shows unrivalled high packing density with ultra low on-resistance and superior switching characteristics. Process simplification also translates into improved manufacturing reproducibility. This device is particularly suitable for high current, low voltage switching application where efficiency is crucial.

APPLICATIONS

- BUCK CONVERTERS IN HIGH PERFORMANCE TELECOM AND VRMs DC-DC CONVERTERS

ABSOLUTE MAXIMUM RATINGS

| Symbol | Parameter | Value | Unit |
|---------------------|--|------------|------|
| V _{DS} | Drain-source Voltage (V _{GS} = 0) | 20 | V |
| V _{DGR} | Drain-gate Voltage (R _{GS} = 20 kΩ) | 20 | V |
| V _{GS} | Gate-source Voltage | ± 15 | V |
| I _D (**) | Drain Current (continuous) at T _C = 25°C | 160 | A |
| I _D | Drain Current (continuous) at T _C = 100°C | 113 | A |
| I _{DM} (●) | Drain Current (pulsed) | 640 | A |
| P _{TOT} | Total Dissipation at T _C = 25°C | 210 | W |
| | Derating Factor | 1.4 | W/°C |
| E _{AS} (1) | Single Pulse Avalanche Energy | 330 | mJ |
| T _{stg} | Storage Temperature | -65 to 175 | °C |
| T _j | Max. Operating Junction Temperature | 175 | °C |

(●) Pulse width limited by safe operating area

(1) V_{DD} = 35V, I_D = 45A, R_G = 22Ω, L = 330μH, Starting T_j=25°C

(**) Limited only maximum junction temperature allowed by PowerSO-10

STV160NF02L

THERMAL DATA

| | | | |
|----------------|--|------|------|
| Rthj-case | Thermal Resistance Junction-case Max | 0.71 | °C/W |
| Rthj-amb | Thermal Resistance Junction-ambient Max | 50 | °C/W |
| T _l | Maximum Lead Temperature For Soldering Purpose | 300 | °C |

ELECTRICAL CHARACTERISTICS (TCASE = 25 °C UNLESS OTHERWISE SPECIFIED)

OFF

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|------------------|---|---|------|------|---------|----------|
| V(BR)DSS | Drain-source Breakdown Voltage | I _D = 250 μA, V _{GS} = 0 | 20 | | | V |
| I _{DSS} | Zero Gate Voltage Drain Current (V _{GS} = 0) | V _{DS} = Max Rating V _{DS} = Max Rating, T _C = 125 °C | | | 1 10 | μA μA |
| I _{GSS} | Gate-body Leakage Current (V _{DS} = 0) | V _{GS} = ± 15 V | | | ±100 | nA |

ON (1)

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|---------------------|-----------------------------------|--|------|---------------------------|--|--|
| V _{GS(th)} | Gate Threshold Voltage | V _{DS} = V _{GS} , I _D = 250 μA | 1 | | | V |
| R _{DS(on)} | Static Drain-source On Resistance | V _{GS} = 10 V, I _D = 80 A V _{GS} = 10 V, I _D = 45 A V _{GS} = 8 V, I _D = 80 A V _{GS} = 5 V, I _D = 40 A V _{GS} = 10 V, I _D = 80 A; T _j = 175 °C V _{GS} = 8 V, I _D = 80 A; T _j = 175 °C V _{GS} = 5 V, I _D = 40 A; T _j = 175 °C | | 1.6 1.56 1.7 3.5 | 2.5 2.5 3.5 6 5.7 7 11.4 | mΩ mΩ mΩ mΩ mΩ mΩ mΩ |
| I _{D(on)} | On State Drain Current | V _{DS} > I _{D(on)} × R _{DS(on)max} , V _{GS} = 10V | 160 | | | A |

DYNAMIC

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|--|---|---|---|-----------------------|------|----------------|
| g _{fs} (1) | Forward Transconductance | V _{DS} > I _{D(on)} × R _{DS(on)max} , I _D = 80A | | 210 | | S |
| R _g | Gate resistance | V _{DS} = 0 V, f = 1 MHz, V _{GS} = 0 | | 0.5 | | Ω |
| C _{iss} C _{oss} C _{rss} | Input Capacitance Output Capacitance Reverse Transfer Capacitance | V _{DS} = 15 V, f = 1 MHz, V _{GS} = 0 | | 4800 3000 680 | | pF pF pF |
| C _{iss} C _{oss} C _{rss} | Input Capacitance Output Capacitance Reverse Transfer Capacitance | V _{DS} = 0 V, f = 1 MHz, V _{GS} = 0 | | 7000 12300 4200 | | pF pF pF |
| L _S | Internal Source Inductance | From the Lead End (6mm from Package Body) to the Die Center | | 4 | | nH |
| L _D | Internal Drain Inductance | | Not Available on Surface Mounting Package | | | |

ELECTRICAL CHARACTERISTICS (CONTINUED)

SWITCHING ON

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|-------------------------------|--|---|------|-----------------|------|----------------|
| $t_{d(on)}$ | Turn-on Delay Time | $V_{DD} = 10 \text{ V}$, $I_D = 80 \text{ A}$ $R_G = 4.7\Omega$, $V_{GS} = 10 \text{ V}$ (see test circuit, Figure 3) | | 28 | | ns |
| t_r | Rise Time | | | 800 | | ns |
| Q_g Q_{gs} Q_{gd} | Total Gate Charge Gate-Source Charge Gate-Drain Charge | $V_{DD} = 16 \text{ V}$, $I_D = 160 \text{ A}$, $V_{GS} = 10 \text{ V}$ | | 115 15 45 | 160 | nC nC nC |

SWITCHING OFF

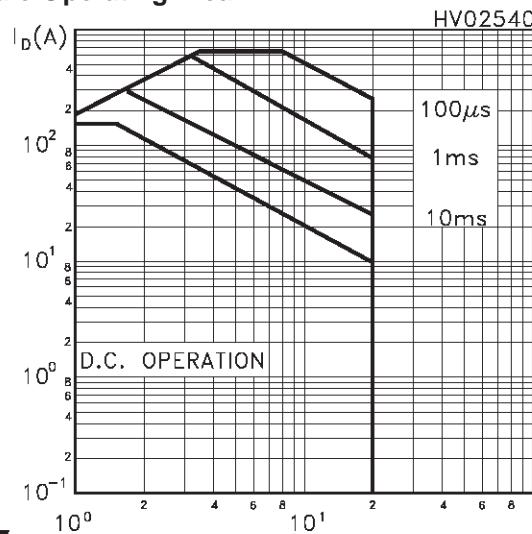
| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|--|--|---|------|------------------------|------|----------------------|
| $t_{d(off)}$ t_f | Turn-off-Delay Time Fall Time | $V_{DD} = 10 \text{ V}$, $I_D = 80 \text{ A}$, $R_G = 4.7\Omega$, $V_{GS} = 10 \text{ V}$ (see test circuit, Figure 5) | | 80 240 | | ns ns |
| $t_{d(off)}$ $t_{r(V_{off})}$ t_f t_c | Turn-off Delay Time Off-voltage Rise Time Fall Time Cross-over Time | $V_{clamp} = 16 \text{ V}$, $I_D = 40 \text{ A}$ $R_G = 4.7\Omega$, $V_{GS} = 10 \text{ V}$ | | 80 40 140 200 | | ns ns ns ns |

SOURCE DRAIN DIODE

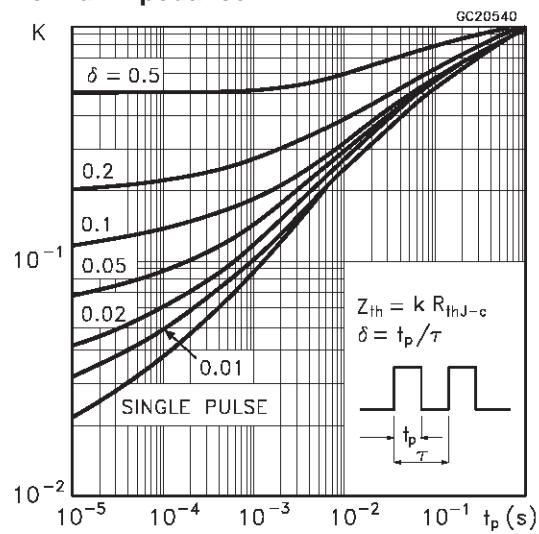
| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|-----------------------------------|--|---|------|----------------|------|---------------|
| I_{SD} | Source-drain Current | | | | 160 | A |
| $I_{SDM(1)}$ | Source-drain Current (pulsed) | | | | 640 | A |
| $V_{SD}(2)$ | Forward On Voltage | $I_{SD} = 160 \text{ A}$, $V_{GS} = 0$ | | | 1.5 | V |
| t_{rr} Q_{rr} I_{RRM} | Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current | $I_{SD} = 80 \text{ A}$, $dI/dt = 100 \text{ A}/\mu\text{s}$, $V_{DD} = 15 \text{ V}$, $T_j = 25^\circ\text{C}$ (see test circuit, Figure 5) | | 90 225 5 | | ns nC A |

Note: 1. Pulsed: Pulse duration = 300 μs , duty cycle 1.5 %.
2. Pulse width limited by safe operating area.

Safe Operating Area

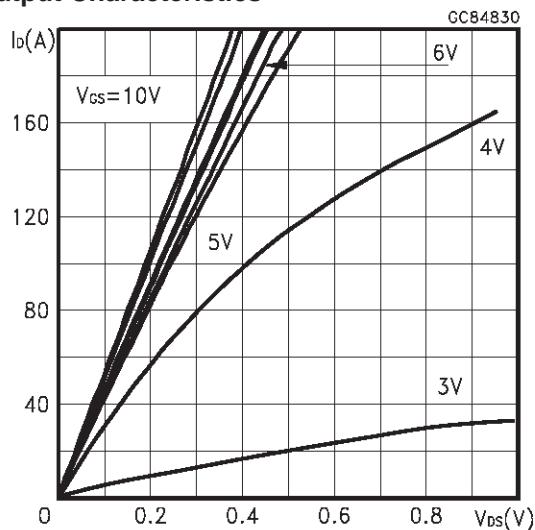


Thermal Impedance

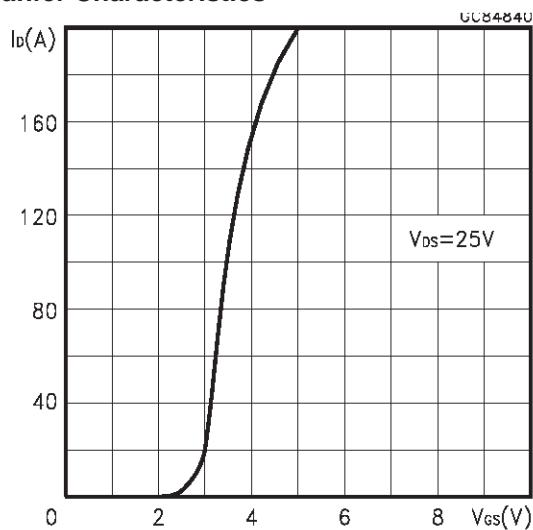


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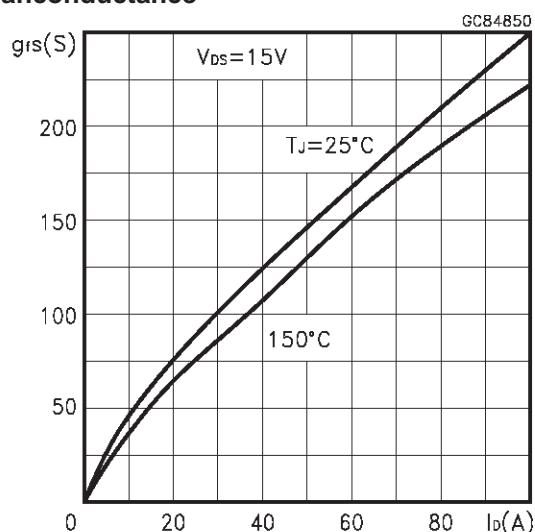
Output Characteristics



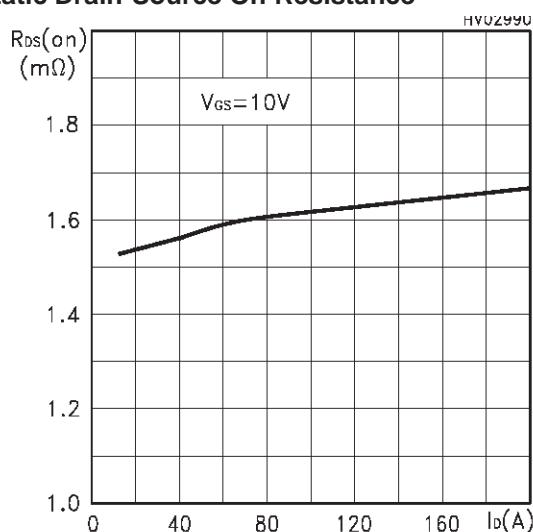
Transfer Characteristics



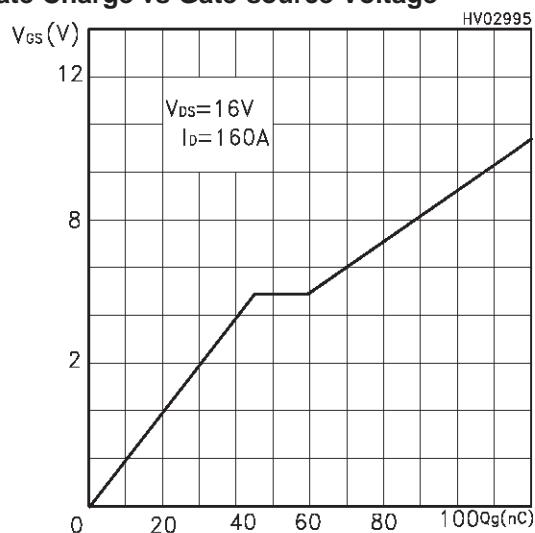
Transconductance



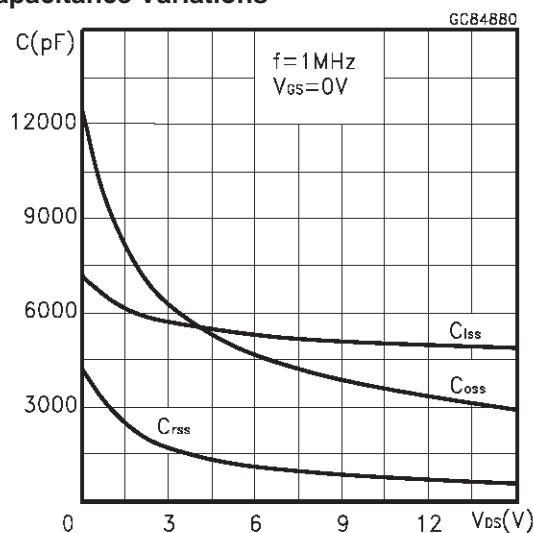
Static Drain-Source On Resistance



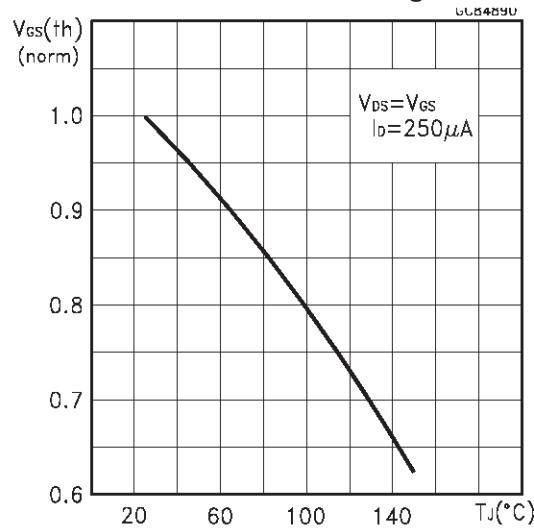
Gate Charge vs Gate-source Voltage



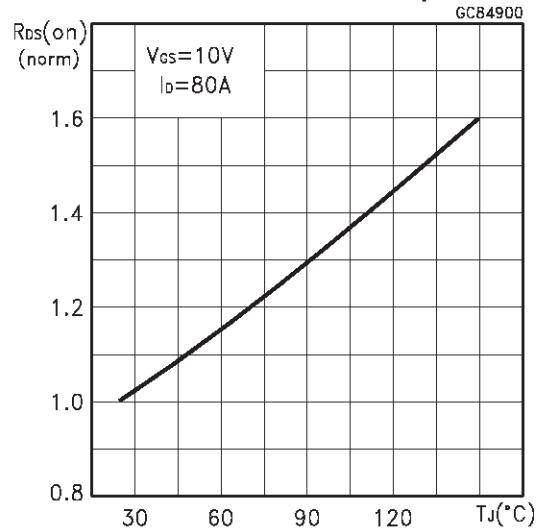
Capacitance Variations



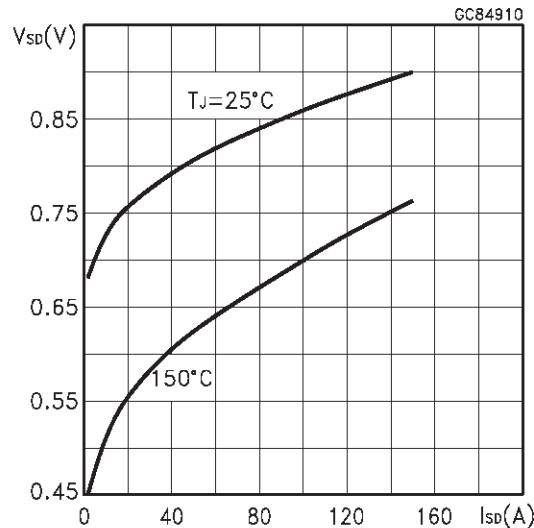
Normalized Gate Threshold Voltage vs Temp.



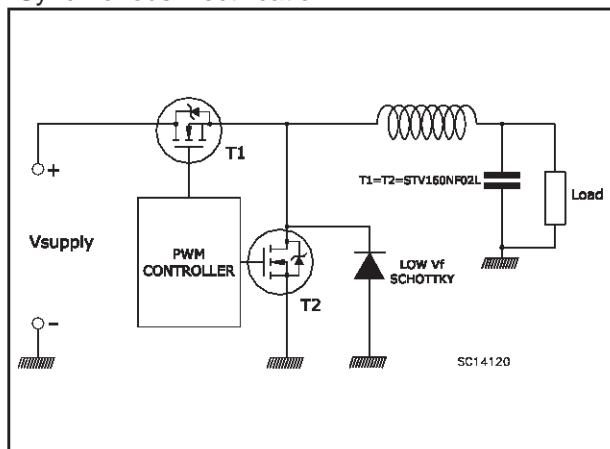
Normalized On Resistance vs Temperature



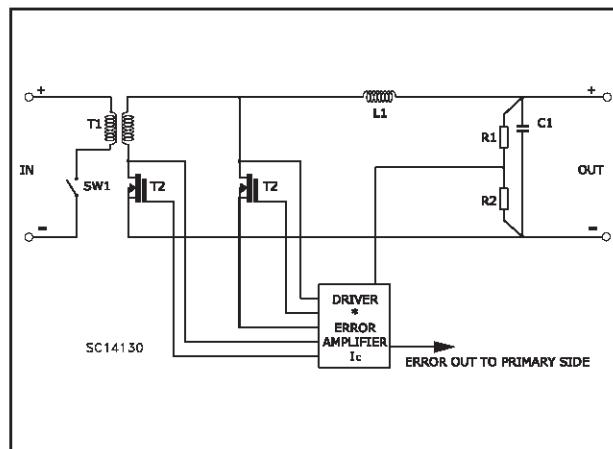
Source-drain Diode Forward Characteristics



Basic Schematic For Motherboard VRM Whith Synchronous Rectification



Basic Schematic Mosfets Switch Used In Secondary Side Of a Froward Convert



STV160NF02L

Fig. 1: Unclamped Inductive Load Test Circuit

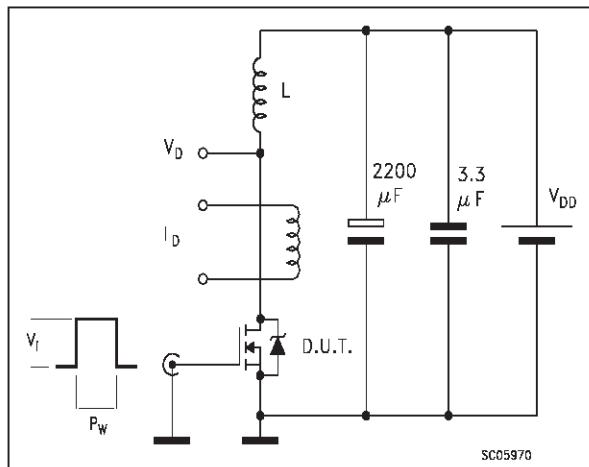


Fig. 2: Unclamped Inductive Waveform

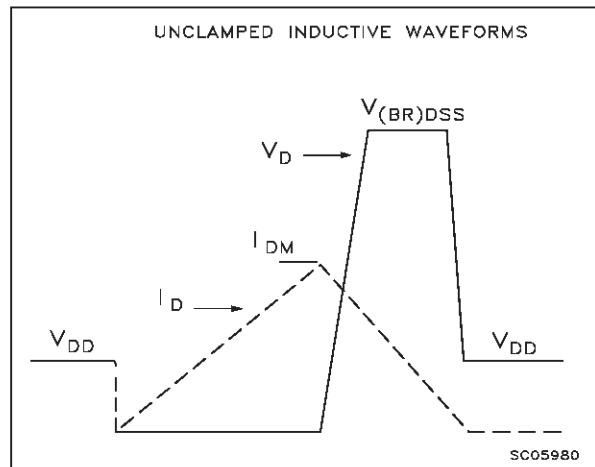


Fig. 3: Switching Times Test Circuit For Resistive Load

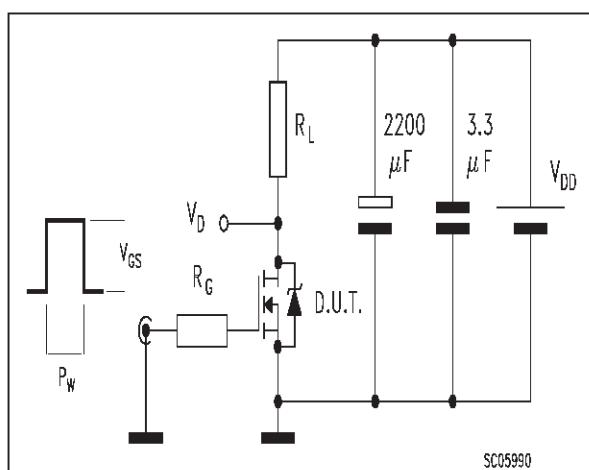


Fig. 4: Gate Charge test Circuit

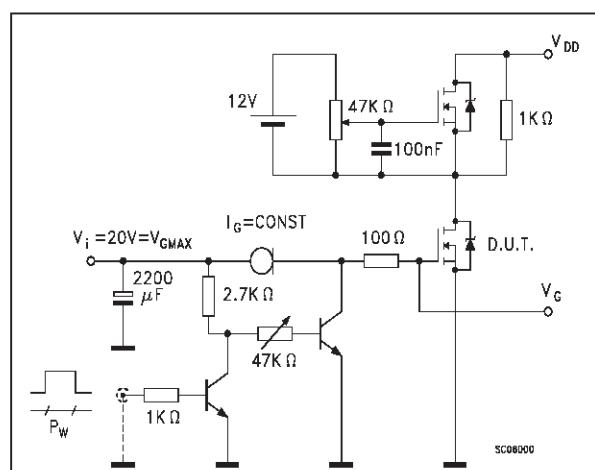
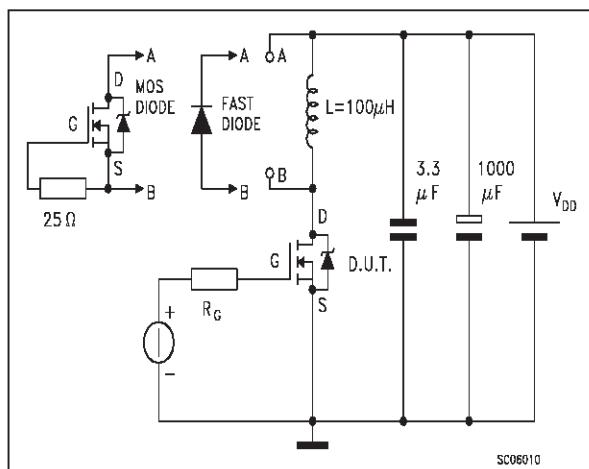
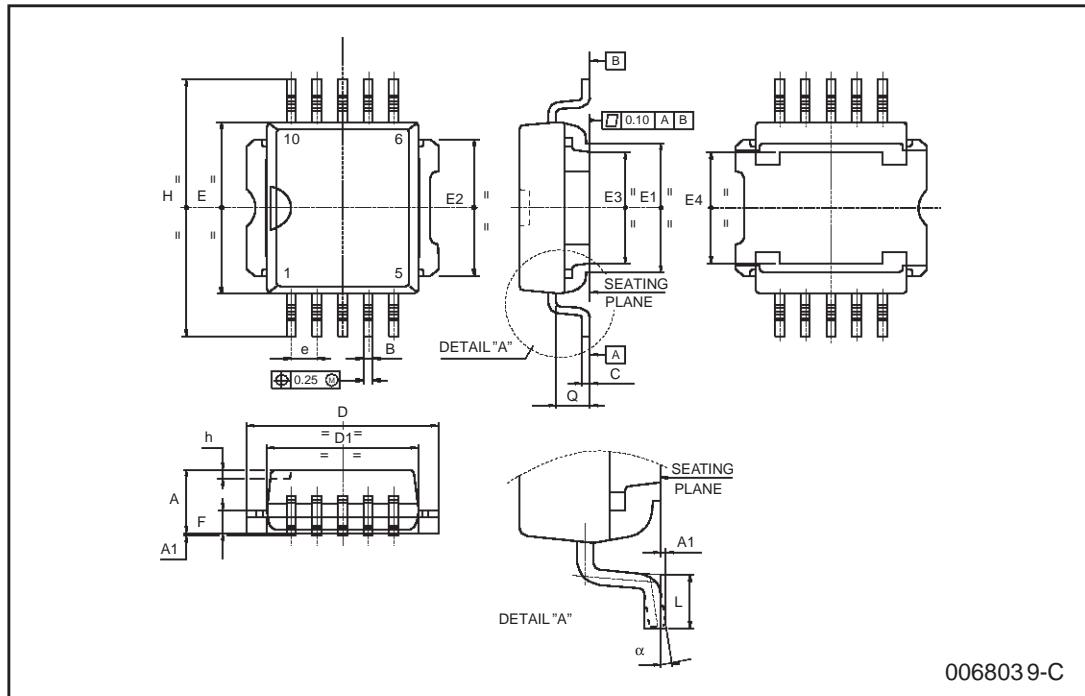


Fig. 5: Test Circuit For Inductive Load Switching And Diode Recovery Times



PowerSO-10 MECHANICAL DATA

| DIM. | mm | | | inch | | |
|----------|-------|------|-------|-------|-------|-------|
| | MIN. | TYP. | MAX. | MIN. | TYP. | MAX. |
| A | 3.35 | | 3.65 | 0.132 | | 0.144 |
| A1 | 0.00 | | 0.10 | 0.000 | | 0.004 |
| B | 0.40 | | 0.60 | 0.016 | | 0.024 |
| C | 0.35 | | 0.55 | 0.013 | | 0.022 |
| D | 9.40 | | 9.60 | 0.370 | | 0.378 |
| D1 | 7.40 | | 7.60 | 0.291 | | 0.300 |
| e | | 1.27 | | | 0.050 | |
| E | 9.30 | | 9.50 | 0.366 | | 0.374 |
| E1 | 7.20 | | 7.40 | 0.283 | | 0.291 |
| E2 | 7.20 | | 7.60 | 0.283 | | 0.300 |
| E3 | 6.10 | | 6.35 | 0.240 | | 0.250 |
| E4 | 5.90 | | 6.10 | 0.232 | | 0.240 |
| F | 1.25 | | 1.35 | 0.049 | | 0.053 |
| h | | 0.50 | | | 0.002 | |
| H | 13.80 | | 14.40 | 0.543 | | 0.567 |
| L | 1.20 | | 1.80 | 0.047 | | 0.071 |
| q | | 1.70 | | | 0.067 | |
| α | 0° | | 8° | | | |



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